Information Disclosure Statement U.S.S.N. 09/446,738

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RECEIVED

LIST OF PATENTS AND	ATTY DOCKET NO. U.S. SERIAL NO. 09/44 Group 2			
PUBLICATIONS (MAR 2 7 2000 7	APPLICANT Yuval Cohen, et al.			
P. F. C.	FILING DATE December 23, 1999	GROUP not yet assigned		

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name		Sub- class	Filing Date if Appropriate
A6	5,181,248	1/19/93	Inanaga et al.			
AG	5,452,359	9/19/95	Inanaga et al.			
AG	5,495,534	2/27/96	Inanaga et al.			

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	DOCUMENT NUMBER	Pub DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES/NO
A6	DE 26 52 101	5/18/78	Germany			Yes
A6	DE 43 32 504 A1	3/30/95	Germany			Yes
A6	EP 0 705 053 A2	4/3/96	EPO			
A6	EP 0 438 281 A2	7/24/91	EPO			
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A6	EP 0 438 281 B1	7/24/96 (granted)	EPO			
AG	EP 0 100 153 A	2/8/84	EPO			
A6	FR 2 237 386	2/7/75	France			Yes

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
Andres Deston	8.1(.03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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January 3, 2003
Page 3

Form PTO-1449 (M. 1971)	ATTY DOCKET NO. B-3833PCT 620100-2	U.S. SERIAL NO. 09/446,738	
LIST OF PATENTS AND PUBLICATIONS STATEMENT	INTERNATIONAL APPLICATION NO. PCT/IL98/00297	INTERNATIONAL FILING DATE 24 June 1908	VFD
	APPLICANT(S) Yuval Cohen, et al.	JAN 1 5	
	FILING DATE February 18, 2000	GRECTINOlogy Ce	nter 2600

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE or 102(e) DATE IF APPROPRIATE
16	5,255,326	10/93	Stevenson	381	110	
46	5,386,478	1/95	Plunkett	381	103	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
16	09-238390	9/97	JP			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Air	Abstract	of JP	09-238390,	Patent	Abstracts	of Japan,	1997.

EXAMINER	DATE CONSIDERED
frew Gala	8.11.03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Information DisclosuSSN 09/446,738 January 30, 2003 Page 3 FEB 0, 6: 2003

Form PTO-1449 (Modification	ATTY DOCKET NO. B-3833PCT 620100-2	U.S. SERIAL NO. 09/446,738
LIST OF PATENTS AND PUBLICATIONS STATEMENT	INTERNATIONAL APPLICATION NO. PCT/IL98/00297	INTERNATIONAL FILING DATE 24 June 1998
	APPLICANT(S) Yuval Cohen, et al.	
	FILING DATE February 18, 2000	group 2749

U.S. PATENT DOCUMENTS

	 				
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X6°	42-227	1/42	JР			
AG	54-19242	7/79	JP			

_		OTHER	DOCUMENTS	(Including	Author,	Title,	Date,	Pertinent	Pages,	Etc.)
	<u> </u>									

EXAMINER	DATE CONSIDERED
John Sichen	a.1(.03

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